

SKN 141F



Stud Diode

Fast Recovery Rectifier Diode

SKN 141F
SKR 141F

Features

- Small recovered charge
- Soft recovery
- Hermetic metal case with glass insulator
- Threaded stud M12
- SKN: anode to stud;
SKR: cathode to stud

Typical Applications

- Inverse diode for GTO and asymmetric thyristor
- Inverters and choppers
- A.C. motor control
- Uninterruptible power supplies (UPS)

V_{RSM} V	V_{RRM} V	$I_{FRMS} = 260$ A (maximum value for continuous operation) $I_{FAV} = 140$ A (sin. 180; 1000 Hz; $T_c = 100$ °C)		
1200	1200	SKN 141F12	SKR 141F12	
1400	1400	SKN 141F14	SKR 141F14	
1500	1500	SKN 141F15	SKR 141F15	
1700	1700	SKN 141F17	SKR 141F17	

Symbol	Conditions	Values	Units
I_{FAV}	sin. 180; $T_c = 85$ (100) °C	168 (140)	A
I_{FAV}	K1,1F; $T_a = 35$ °C; sin. 180; 1000 Hz	114	A
I_{FSM}	$T_{vj} = 25$ °C; 10 ms	2500	A
	$T_{vj} = 150$ °C; 10 ms	2100	A
i^2t	$T_{vj} = 25$ °C; 8,3 ... 10 ms	31000	A ² s
	$T_{vj} = 150$ °C; 8,3 ... 10 ms	22000	A ² s
V_F	$T_{vj} = 25$ °C; $I_F = 300$ A	max. 1,8	V
$V_{(TO)}$	$T_{vj} = 150$ °C	max. 1,1	V
r_T	$T_{vj} = 150$ °C	max. 2	mΩ
I_{RD}	$T_{vj} = 25$ °C; $V_{RD} = V_{RRM}$	max. 1	mA
I_{RD}	$T_{vj} = 150$ °C; $V_{RD} = V_{RRM}$	max. 100	mA
Q_{rr}	$T_{vj} = 150$ °C; $I_F = 100$ A,	90	μC
I_{RM}	$-di/dt = 100$ A/μs, $V_R = 400$ V	90	A
t_{rr}		2000	ns
E_{rr}		-	mJ
$R_{th(j-c)}$		0,2	K/W
$R_{th(c-s)}$		0,08	K/W
T_{vj}		- 40 ... + 150	°C
T_{stg}		- 55 ... + 150	°C
V_{isol}		-	V~
M_s	to heatsink	10	Nm
a		$5 \cdot 9,81$	m/s ²
m	approx.	100	g
Case		E 31	



SKN



SKR

SKN 141F

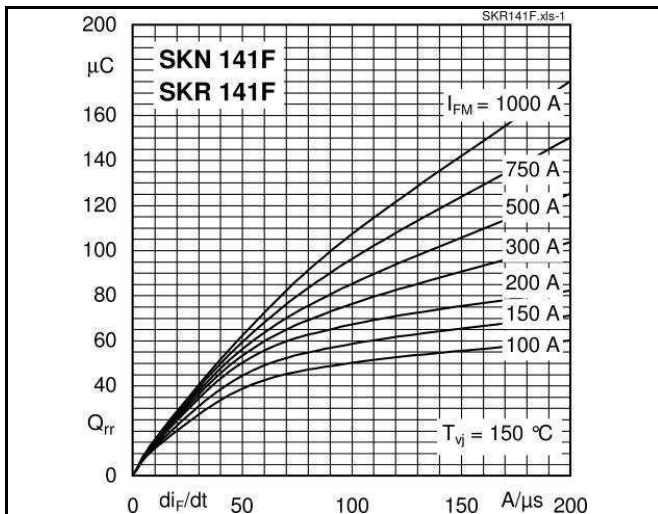


Fig. 1 Typ. recovery charge vs. current decrease

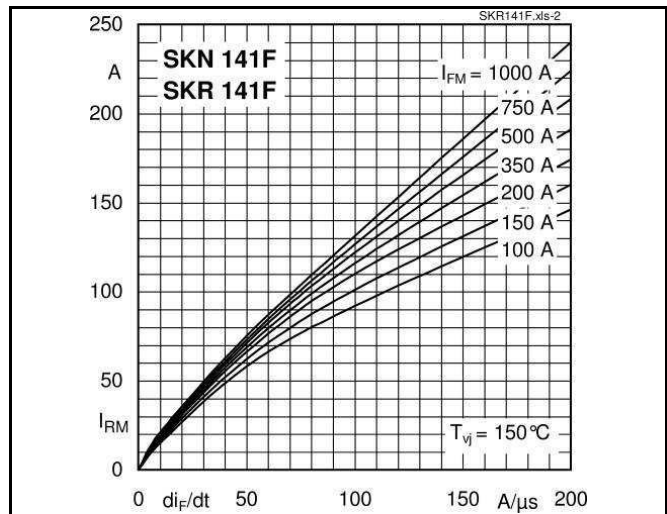


Fig. 2 Peak recovery current vs. current decrease

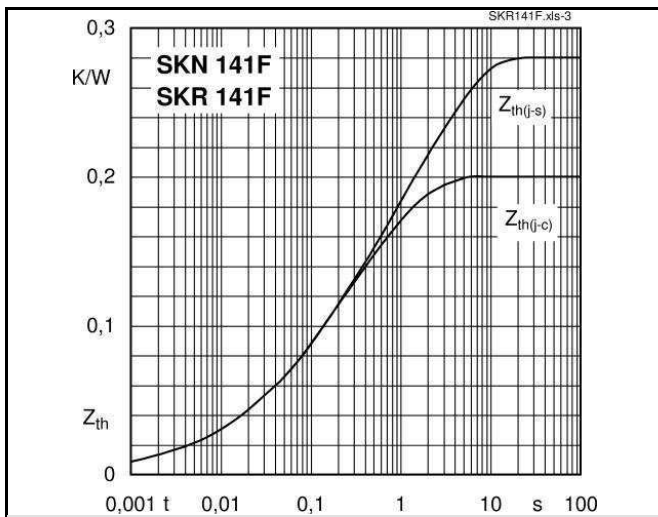


Fig. 3 Transient thermal impedance vs. time

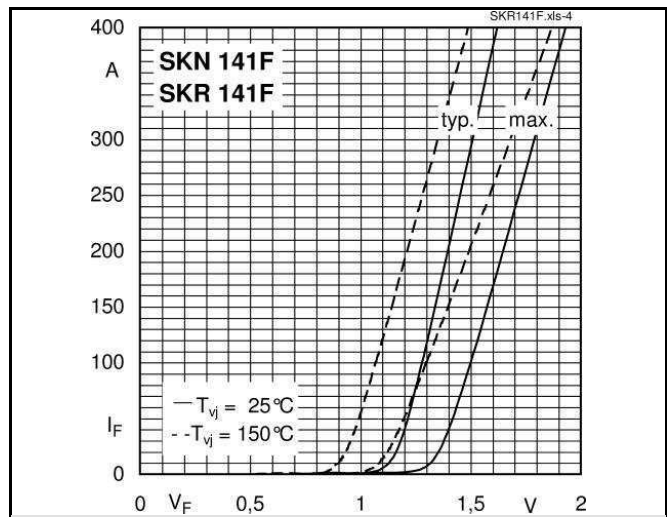


Fig. 4 Forward characteristics

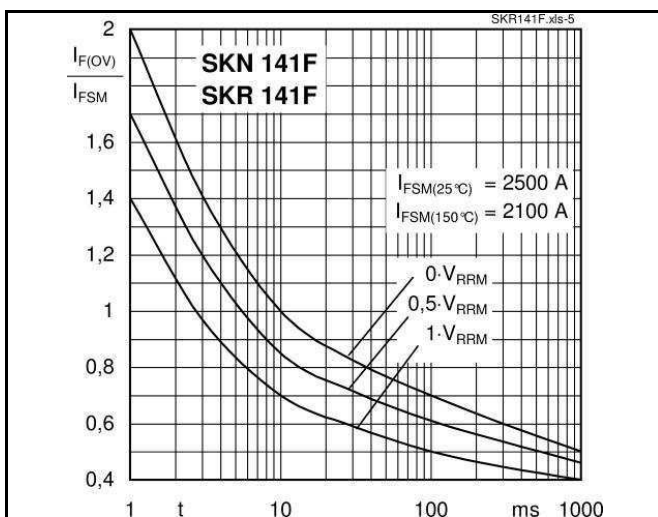
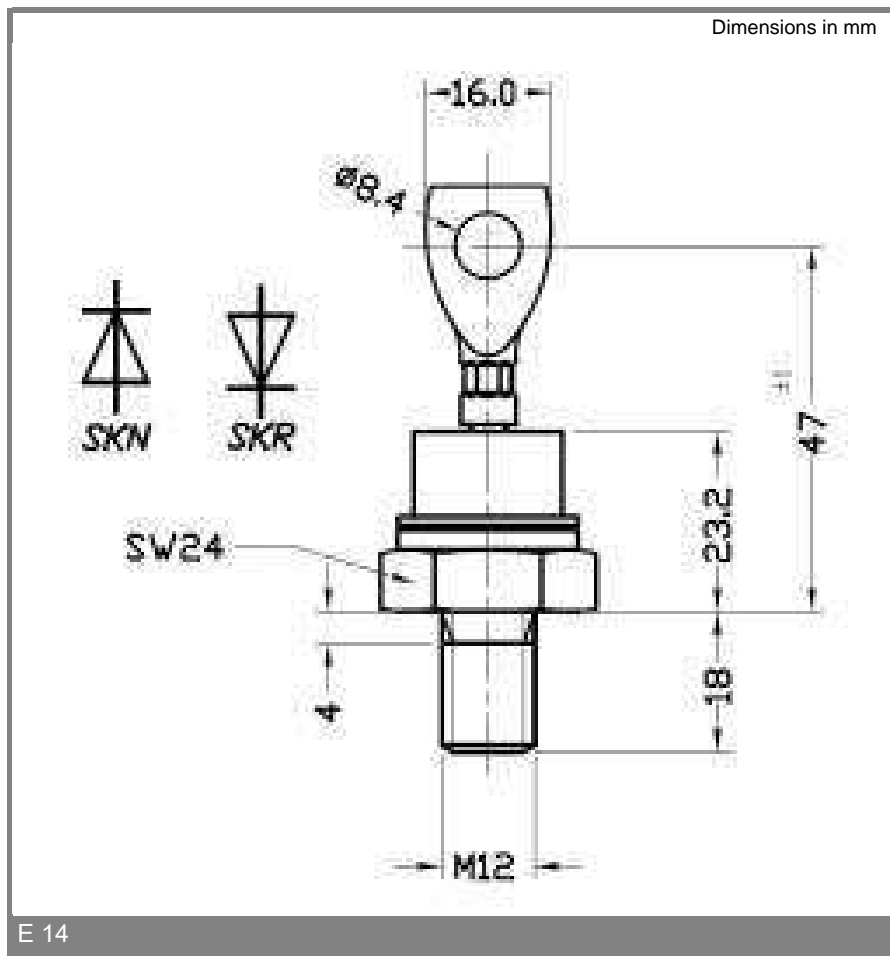


Fig. 5 Surge overload current vs. time

SKN 141F



This technical information specifies semiconductor devices but promises no characteristics. No warranty or guarantee expressed or implied is made regarding delivery, performance or suitability.